imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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30 MHz Delay Trace Analog Oscilloscope With Probes Model 2125A

B&K Precision's model 2125A is a dual trace oscilloscope with a delayed sweep that offers high performance at a low price. Most competitor's entry level oscilloscopes have a 20 MHz bandwidth, while B&K Precision's models 2125A has a bandwidth of 30 MHz. This oscilloscope is built by and backed by B&K Precision, a company that has been selling reliable, durable, value priced test instruments for over 50 years.

- Delayed sweep in 23 steps
- Built in component tester for capacitors, inductors, diodes, transistors, zener diodes
- 23 step time base to 0.1 ms/div
- Deluxe handle/tilt stand
- cUL certified



Specifications	2125A
VERTICAL AMPLIFIERS (CH 1	and CH 2)
Sensitivity	5 mV/div to 5 V/div, 1 mV/div to 1 V/div at x5
Attenuator	10 steps in 1-2-5 sequence. Vernier control provides full adjustment between steps
Accuracy	$\pm 3\%, \pm 5\%$ at x5
Input Resistance	$1 \text{ M}\Omega + 2\%$
Input Capacitance	25 pF ± 10pF
Frequency Response	5 mV to 5 V/div: DC to 30 MHz (-3dB), X5: DC to 10 MHz (-3dB)
Rise Time	12ns (Overshoot ≤5%)
Operating Modes	CH 1: CH 1, single trace
CH 2	CH 2, single trace
ALT	dual trace, alternating
CHOP	dual trace, chopped
ADD	agebraic sum of CH 1 + CH 2
Polarity Reversal	CH 2 only
Max. Input Voltage	400 V (DC to AC peak)
SWEEP SYSTEM	
Operating Modes	Main, mix (both main sweep and delay sweep displayed), or Delay (only delay sweep displayed), X-Y
Main Sweep SpeeD	0.1 µs/div to 2.0 s/div in 1-2-5 sequence, 23 steps Vernier control provides fully adjustable sweep time between steps
Accuracy	±3%
Sweep Magnification	10X. ±5%
Delayed Sweep Speed	0.1 ms/div to 0.1s/div in 1-2-5 sequence, 23 steps
Holdoff	Continuously variable for Main sweep up to 10 times normal
Delay Time Position	Continuously variable to control percentage of display that is devoted to main and delay sweet
TRIGGERING	
Triggering Modes	AUTO (free run) or NORM, TV-V, TV-H
00 0	al CH 1, CH 2, ALT, EXT, LINE
00	300 V (DC + AC peak)
Trigger Voltage	
Trigger Coupling	AC 30 Hz to 30 MHz, TV H Used for triggering from horizontal sync pulses, TV V Used for triggering from vertical sync pulses
TRIGGER SENSITIVITY	
Auto	Bandwidth: 100Hz - 40MHz, Internal: 1.5 div, External: ≥0.1Vp-p
Norm	Bandwidth: 100Hz - 40MHz, Internal: 1.5 div. External: ≥0.1Vp-p
TV-V	Bandwidth: DC -1kHz, Internal: 0.5 div, External: ≥0.05Vp-p
TV-H	I kHz - 100kHz, Internal: 0.5 div, External: ≥0.05Vp-p
HORIZONTAL AMPLIFIER (Inp	
X-Y Mode	Switch selectable using X-Y switch. CH 1: X axis, CH 2: Y axis
Sensitivity	Same as vertical channel 2
Accuracy	Y-Axis: ±3%. X-Axis: ±6%
Input Impedance	ame as vertical channel 2
Frequency Response	DC to 1MHz typical (-3 dB), to 6 div horizontal deflection
X-Y Phase Difference	3° or less at 50 kHz
Max. Input Voltage	Same as vertical channel 2
CRT	
Туре	Rectangular with internal graticule
Display Area	$8 \times 10 \text{ div} (1 \text{ div} = 1 \text{ cm})$
Accelerating Voltage	2 kV
Phosphor	P31
Trace Rotation	Electrical, front panel adjustable
COMPONENT TESTER	
	Resistors, Capacitors, Inductors, and Semiconductors
COMPONENT TESTER	
COMPONENT TESTER Components Tested	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 1 I mA maximim (shorted)
COMPONENT TESTER Components Tested Test Voltage	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open)
COMPONENT TESTER Components Tested Test Voltage Test Current	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 1 I mA maximim (shorted)
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 1 I mA maximim (shorted) Line Frequency (60 Hz in USA)
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 11 mA maximim (shorted) Line Frequency (60 Hz in USA)
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 11 mA maximim (shorted) Line Frequency (60 Hz in USA) 1 kHz (±10%) Positive Square Wave, 0.2 V p-p (±2%) Within Specified Accuracy: 50° to 95°F (10° to 35°C), <855% RH
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage GENERAL	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 11 mA maximim (shorted) Line Frequency (60 Hz in USA) 1 kHz (±10%) Positive Square Wave, 0.2 V p-p (±2%) Within Specified Accuracy: 50° to 95°F (10° to 35°C), <85% RH
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage GENERAL Temperature	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 11 mA maximim (shorted) Line Frequency (60 Hz in USA) 1 kHz (±10%) Positive Square Wave, 0.2 V p-p (±2%) Within Specified Accuracy: 50° to 95°F (10° to 35°C), ≤85% RH Full Operation: 32° to 104° F (0° to 40°C), ≤85% RH Storage: -4° to 158° F (-20° to +70°C)
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage GENERAL Temperature Power Requirements	Resistors, Capacitors, Inductors, and Semiconductors 6 V rms maximum (open) 11 mA maximin (shorted) Line Frequency (60 Hz in USA) 1 kHz (±10%) Positive Square Wave, 0.2 V p-p (±2%) Within Specified Accuracy: 50° to 95°F (10° to 35°C), \$85% RH Full Operation: 32° to 104° F (0° to 40°C), \$85% RH Storage: -4° to 158° F (-20° to +70°C) 100/120/220/240 VAC ± 10%, \$0/60 Hz, Approximately 40 W 7 x 14.5 x 14.25" (180 x 370 x 440 mm)
COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage GENERAL Temperature Power Requirements Dimensions (WXHXD)	Resistors, Capacitors, Inductors, and Semiconductors6 V rms maximum (open)11 mA maximim (shorted)Line Frequency (60 Hz in USA)1 kHz ($\pm 10\%$) Positive Square Wave, 0.2 V p-p ($\pm 2\%$)Within Specified Accuracy: 50° to 95°F (10° to 35°C), ≤85% RHFull Operation: 32° to 104° F (0° to 40°C), ≤85% RHStorage: -4° to 158° F (-20° to +70°C)100/120/220/240 VAC $\pm 10\%$, 50/60 Hz, Approximately 40 W7 x 14 .5 x 14.25° (180 x 370 x 440 mm)Approximately 17.2 lbs (7.8 kg)
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COMPONENT TESTER Components Tested Test Voltage Test Current Test Frequency Calibrating Voltage GENERAL Temperature Power Requirements Dimensions (WxHxD) Weight	Resistors, Capacitors, Inductors, and Semiconductors6 V rms maximum (open)11 mA maximim (shorted)Line Frequency (60 Hz in USA)1 kHz ($\pm 10\%$) Positive Square Wave, 0.2 V p-p ($\pm 2\%$)Within Specified Accuracy: 50° to 95°F (10° to 35°C), \leq 85% RHFull Operation: 32° to 104° F (0° to 40°C), \leq 85% RHStorage: -4° to 158° F (-20° to +70°C)100/120/220/240 VAC $\pm 10\%$, 50/60 Hz, Approximately 40 W7 x 14.5 x 14.25° (180 x 370 x 440 mm)Approximately 17.2 lbs (7.8 kg)

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